Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination NAKANO ET AL.	
10/633,686		
Examiner	Art Unit	
Carlos Lopez	1731	

SEARCHED					
Class	Subclass	Date	Examiner		
264	615	6/12/2006	CL		
361	321.2	6/12/2006	CL		
361	301.4	6/12/2006	CL		
361	312	6/12/2006	CL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING SEARCH	SIRAILGI	<i>)</i>
	DATE	EXMR
EAst (Derwent, USOCR,USPAT,USPGPBUS,JPO,EP O,IBM_TBD)-see search notes.	6/12/2006	CL